

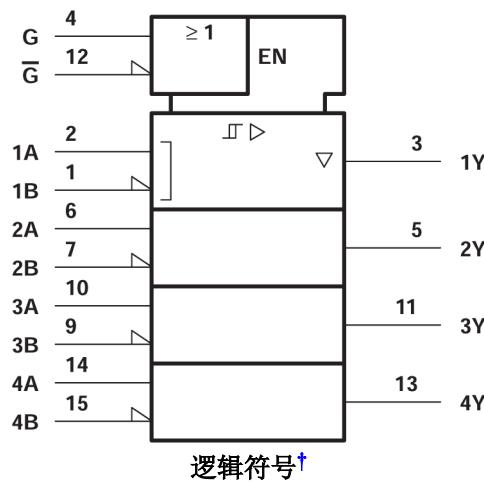
SN75ALS173 四路差分线路接收器

1 特性

- 符合或超出 ANSI EIA/TIA-422-B、EIA/TIA-423-B 和 RS-485 的要求
- 符合或超出 ITU 建议 V.10、V.11、X.26 和 X.27 的要求
- 适用于嘈杂环境中长总线上的多点总线传输
- 三态输出
- 12V 至 12V 的共模输入电压范围
- 输入灵敏度：±200mV
- 输入迟滞：50mV（典型值）
- 高输入阻抗：12kΩ（最小值）
- 由 5V 单电源供电
- 低电源电流要求（最高 27mA）

2 应用

- 电机驱动器
- 工厂自动化和控制

逻辑符号[†]

3 说明

SN75ALS173 是一款具有三态输出的单片四路差分线路接收器，满足 ANSI 标准 EIA/TIA-422-B、EIA/TIA-423-B、RS-485 以及多项 ITU 建议的要求。先进的低功耗肖特基技术可提供高速度，但不会导致常见的功率损耗。四个接收器共用一对进行了“或”运算的使能端。G 高电平或 G 低电平可启用所有接收器。该器件具有高输入阻抗、用于提高抗噪性的输入迟滞、以及在 -12V 至 12V 共模输入电压范围内 ±200mV 的输入灵敏度。

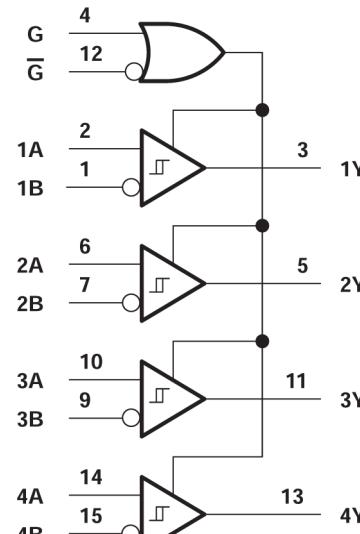
SN75ALS173 的额定工作温度范围为 0°C 至 70°C。

封装信息

器件型号	封装 ⁽¹⁾	封装尺寸 ⁽²⁾
SN75ALS173	N (PDIP , 16)	19.3mm × 9.4mm
	NS (SOP , 16)	10.2mm × 7.8mm

(1) 如需更多信息，请参阅节 10。

(2) 封装尺寸（长 × 宽）为标称值，并包括引脚（如适用）。



逻辑图（正逻辑）

[†] 此符号符合 ANSI/IEEE 标准 91-1984 和 IEC 出版物 617-12。

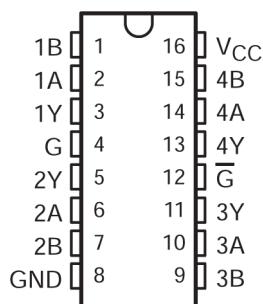


本资源的原文使用英文撰写。为方便起见，TI 提供了译文；由于翻译过程中可能使用了自动化工具，TI 不保证译文的准确性。为确认准确性，请务必访问 ti.com 参考最新的英文版本（控制文档）。

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4 Pin Configuration and Functions



A. The NS package is only available left-end taped and reeled (order device SN75ALS173 NSLE).

图 4-1. N or NS Package (Top View)

表 4-1. Pin Functions

PIN		TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.		
1B	1	I	Channel 1 Differential Receiver Inverting Input
1A	2	I	Channel 1 Differential Receiver Non-Inverting Input
1Y	3	O	Channel 1 Single Ended Output
G	4	I	Active High Enable
2Y	5	O	Channel 2 Single Ended Output
2A	6	I	Channel 2 Differential Receiver Non-Inverting Input
2B	7	I	Channel 2 Differential Receiver Inverting Input
GND	8	GND	Device GND
3B	9	I	Channel 3 Differential Receiver Inverting Input
3A	10	I	Channel 3 Differential Receiver Non-Inverting Input
3Y	11	O	Channel 3 Single Ended Output
\bar{G}	12	I	Active Low Enable
4Y	13	O	Channel 4 Single Ended Output
4A	14	I	Channel 4 Differential Receiver Non-Inverting Input
4B	15	I	Channel 4 Differential Receiver Inverting Input
V _{CC}	16	PWR	Device VCC (4.75 V to 5.25 V)

(1) Signal Types: I = Input, O = Output, I/O = Input or Output.

5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
V _{CC}	Supply voltage, (see ⁽²⁾)		7	V
V _I	Input voltage, (A or B inputs)		±14	V
V _{ID}	Differential input voltage, (see ⁽³⁾)		±14	V
V _I	Enable input voltage		7	V
I _{OL}	Low-level output current		50	mA
	Continuous total dissipation	See Dissipation Rating Table		
T _A	Operating free-air temperature range	0	70	°C
T _{stg}	Storage temperature range	-65	150	°C
	Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds		260	°C

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values, except differential input voltage, are with respect to network ground terminal.
- (3) Differential input voltage is measured at the noninverting input with respect to the corresponding inverting input.

5.2 Dissipation Rating Table

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING
N	1150 mW	9.2 mW/°C	736 mW
NS	625 mW	5.0 mW/°C	400 mW

5.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		4.75	5	5.25	V
Common-mode input voltage, V _{IC}				±12	V
Differential input voltage, V _{ID}				±12	V
High-level input voltage, V _{IH}	G, \bar{G}		2		V
Low-level input voltage, V _{IL}	G, \bar{G}			0.8	V
High-level output current, I _{OH}				-400	µA
Low-level output current, I _{OL}				8	mA
Operating free-air temperature, T _A		0		70	°C

5.4 Thermal Information

THERMAL METRIC ⁽¹⁾		SN75ALS173		UNIT
		N (PDIP)	NS (SOP)	
		16 Pins	16 Pins	
R _{θJA}	Junction-to-ambient thermal resistance	60.6	88.5	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	48.1	46.2	°C/W
R _{θJB}	Junction-to-board thermal resistance	40.6	50.7	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	27.5	13.5	°C/W

5.4 Thermal Information (续)

THERMAL METRIC ⁽¹⁾		SN75ALS173		UNIT
		N (PDIP)	NS (SOP)	
		16 Pins	16 Pins	
Ψ_{JB}	Junction-to-board characterization parameter	40.3	50.3	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC package thermal metrics](#) application report.

5.5 Electrical Characteristics

over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature (unless otherwise noted) (see [Note 3](#))

PARAMETER		TEST CONDITIONS			MIN	TYP ⁽¹⁾	MAX	UNIT	
V_{IT+}	Positive-going input threshold voltage					200		mV	
V_{IT-}	Negative-going input threshold voltage				-200 ⁽²⁾			mV	
V_{hys}	Hysteresis voltage ($V_{IT+} - V_{IT-}$)				50			mV	
V_{IK}	Input clamp voltage G, \bar{G}	$I_I = -18 \text{ mA}$					-1.5	V	
V_{OH}	High-level output voltage	$V_{ID} = 200 \text{ mV}$, $I_{OH} = -400 \mu \text{A}$, See 图 6-1				2.7		v	
V_{OL}	Low-level output voltage	$V_{ID} = -200 \text{ mV}$, $I_{OL} = 8 \text{ mA}$, See 图 6-1					0.45	v	
I_{OZ}	High-impedance-state output current	$V_O = 0.4 \text{ V}$ to 2.4 V					-20	μA	
I_I	Line input current	Other input at 0 V	$V_I = 12 \text{ V}$				1	μA	
I_{IH}	High-level input current G, \bar{G}		$V_I = -7 \text{ V}$				-0.8		
I_{IL}	Low-level input current G, \bar{G}	$V_{IL} = 0.4 \text{ V}$					-100	μA	
r_i	Input resistance				12			$\text{k}\Omega$	
I_{os}	Short-circuit output current	See Note 4				-15	-85	mA	
I_{cc}	Supply current (total package)	No load,	Outputs enabled				16	24	mA
		No load,	Outputs disabled				18	27	

(1) All typical values are at $V_{CC} = 5 \text{ V}$ and $T_A = 25^\circ\text{C}$.

(2) The algebraic convention, in which the less positive (more negative) limit is designated as minimum, is used in this data sheet for threshold voltage levels only.

(3) Refer to ANSI Standard RS-485 for exact conditions.

(4) The duration of the short circuit should not cause the maximum package power dissipation to be exceeded.

5.6 Switching Characteristics

$V_{CC} = 5 \text{ V}$, $C_L = 15 \text{ pF}$, $T_A = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PHL}	Propagation delay time, high- to low-level output	$V_{ID} = -2.5 \text{ V}$ to 2.5 V , See 图 6-2	9	18	27	ns
t_{PLH}	Propagation delay time, low- to high-level output		9	18	27	ns
t_{PZH}	Output enable time to high level	See 图 6-3	4	12	18	ns
t_{PZL}	Output enable time to low level	See 图 6-4	6	13	21	ns
t_{PHZ}	Output disable time from high level	See 图 6-3	10	21	27	ns
t_{PLZ}	Output disable time from low level	See 图 6-4	8	15	25	ns

6 Parameter Measurement Information

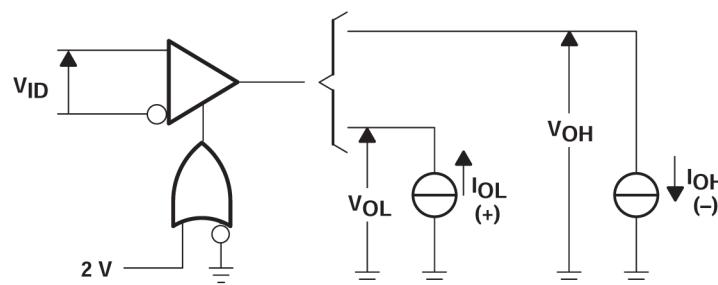
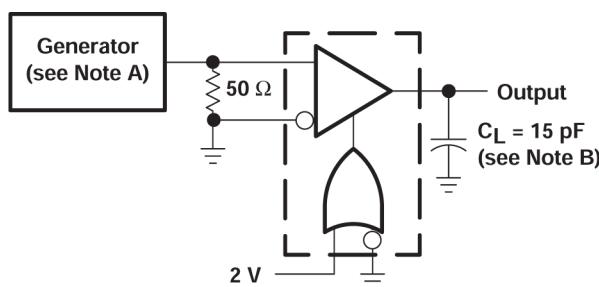
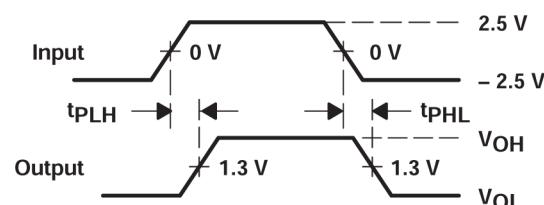


图 6-1. V_{OH} , V_{OL}

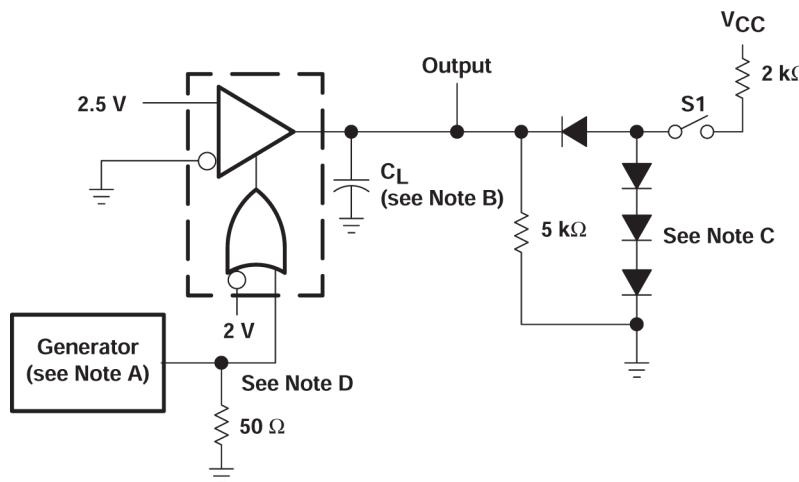


TEST CIRCUIT

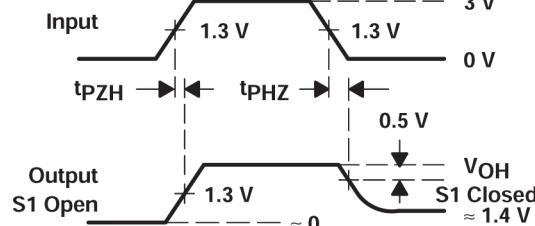


VOLTAGE WAVEFORMS

图 6-2. Test Circuit and Voltage Waveforms



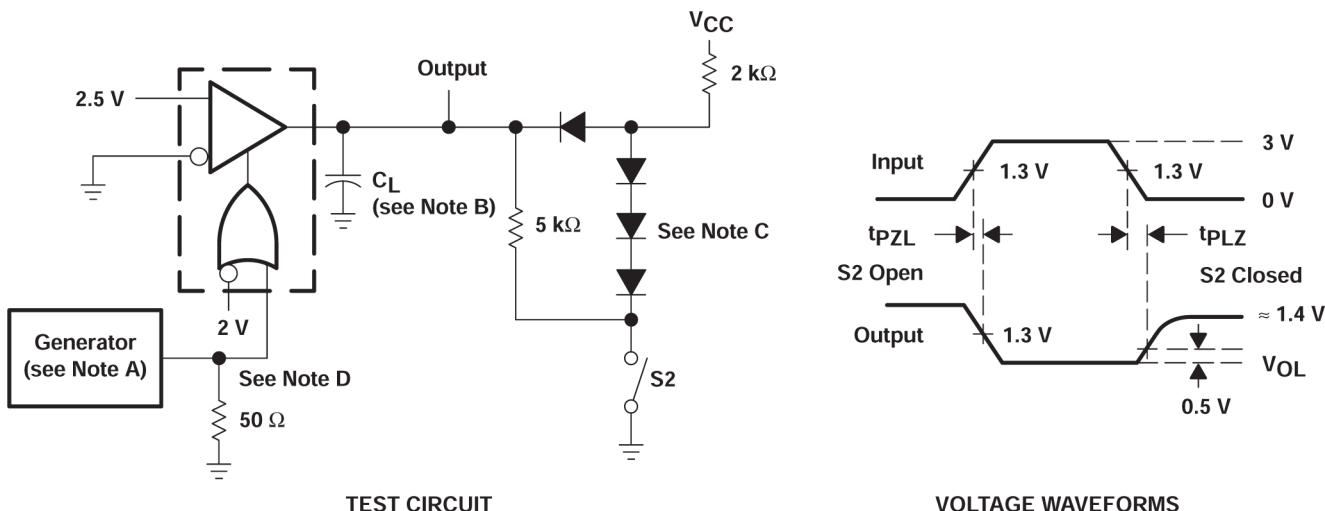
TEST CIRCUIT



VOLTAGE WAVEFORMS

- A. The input pulse is supplied by a generator having the following characteristics: PRR = 1 MHz, duty cycle = 50%, $t_r \leq 6 \text{ ns}$, $t_f \leq 6 \text{ ns}$, $Z_0 = 50 \Omega$.
- B. C_L includes probe and jig capacitance.
- C. All diodes are 1N916 or equivalent.
- D. To test the active-low enable \bar{G} , ground G and apply an inverted input waveform to \bar{G} .

图 6-3. Test Circuit and Voltage Waveforms



- A. The input pulse is supplied by a generator having the following characteristics: PRR = 1 MHz, duty cycle = 50%, $t_r \leq 6$ ns, $t_f \leq 6$ ns, $Z_0 = 50 \Omega$.
- B. C_L includes probe and jig capacitance.
- C. All diodes are 1N916 or equivalent.
- D. To test the active-low enable \overline{G} , ground G and apply an inverted input waveform to \overline{G} .

图 6-4. Test Circuit and Voltage Waveforms

7 Detailed Description

7.1 Device Functional Modes

表 7-1. Function Table (Each Receiver)

DIFFERENTIAL A - B	ENABLES ⁽¹⁾		OUTPUT Y
	G	G	
$V_{ID} \geq 0.2 \text{ V}$	H	X	H
	X	L	H
$-0.2 \text{ V} < V_{ID} < 0.2 \text{ V}$	H	X	?
	X	L	?
$V_{ID} < -0.2 \text{ V}$	H	X	L
	X	L	L
X	L	H	Z
Open Circuit	H	X	H
	X	L	H

(1) H = high level, L = low level, ? = indeterminate, X = irrelevant, Z = high impedance (off)

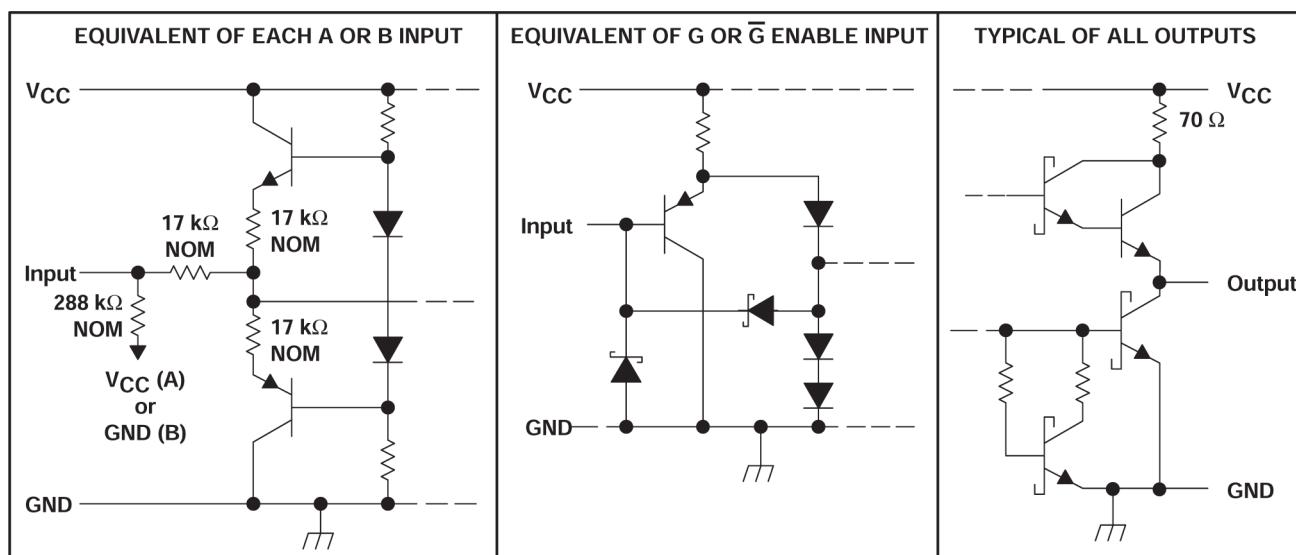


图 7-1. Schematics of Inputs and Outputs

8 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

8.1 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](#) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

8.2 支持资源

[TI E2E™ 支持论坛](#)是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《[使用条款](#)》。

8.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

所有商标均为其各自所有者的财产。

8.4 静电放电警告



静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

8.5 术语表

TI 术语表

本术语表列出并解释了术语、首字母缩略词和定义。

9 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision C (May 1995) to Revision D (October 2023)	Page
• 更改了整个文档中的表格、图和交叉参考的编号格式.....	1

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN75ALS173N	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	0 to 70	SN75ALS173N	Samples
SN75ALS173NSR	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	75ALS173	Samples
SN75ALS173NSRG4	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	75ALS173	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

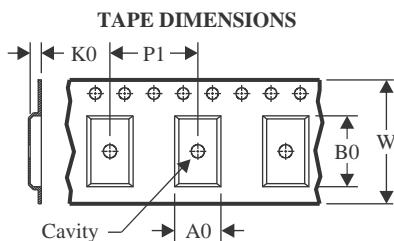
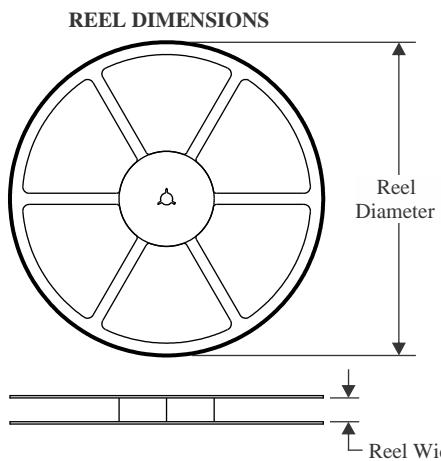
(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

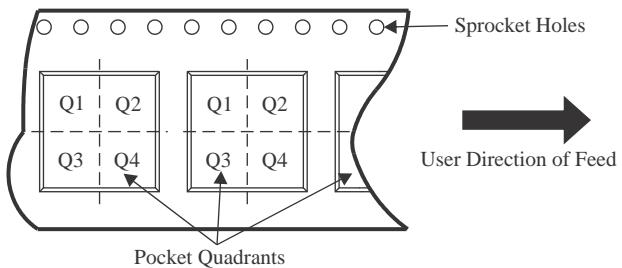
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION



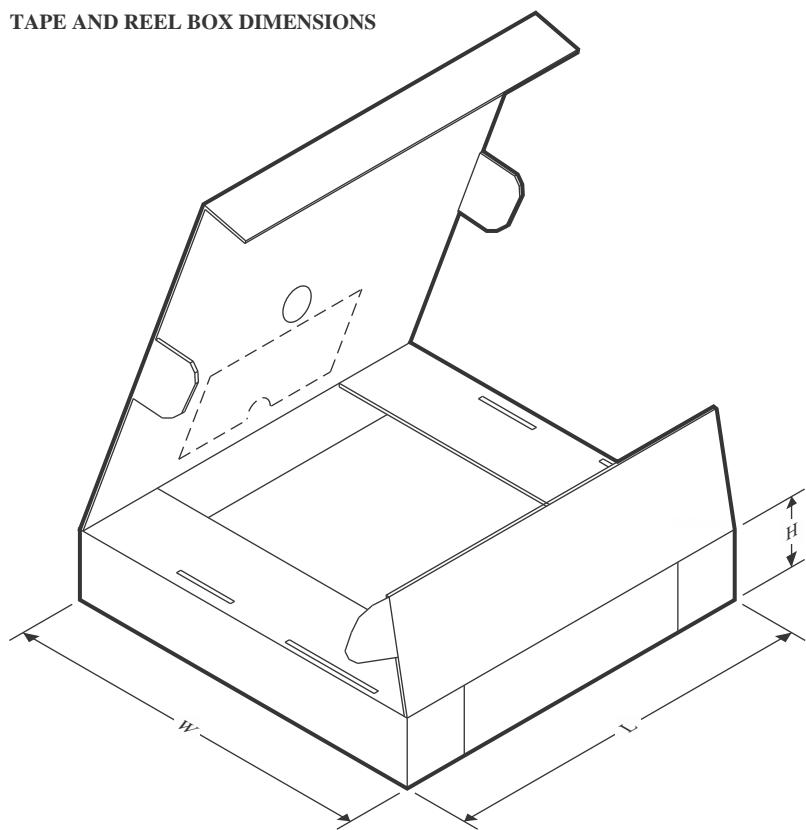
A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



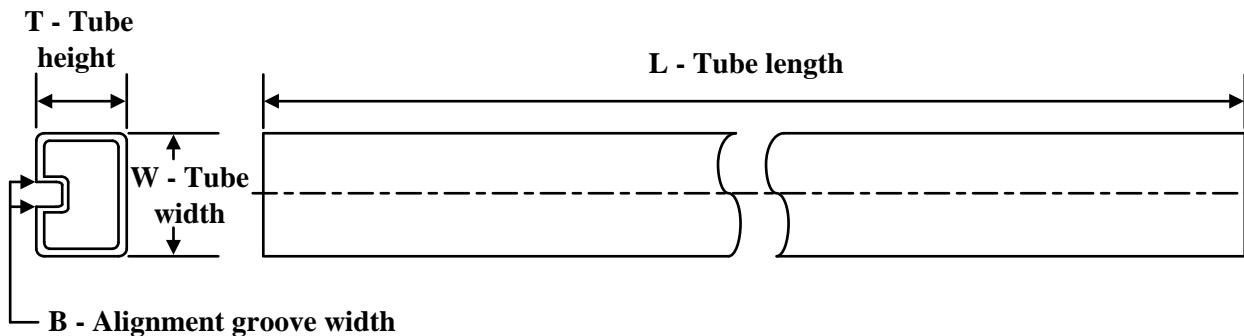
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN75ALS173NSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN75ALS173NSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN75ALS173NSR	SO	NS	16	2000	353.0	353.0	32.0
SN75ALS173NSR	SO	NS	16	2000	367.0	367.0	38.0

TUBE


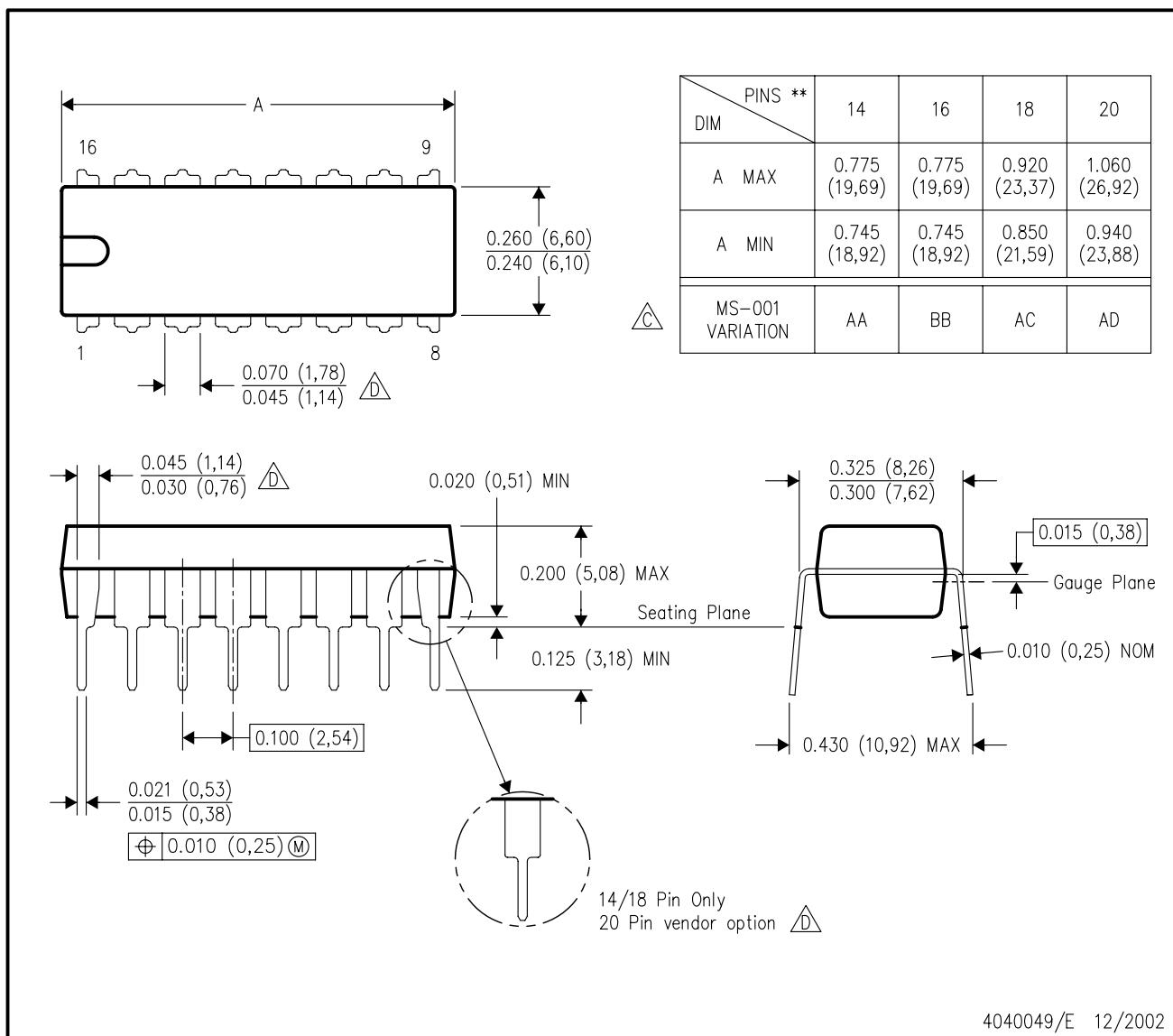
*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μ m)	B (mm)
SN75ALS173N	N	PDIP	16	25	506	13.97	11230	4.32

N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



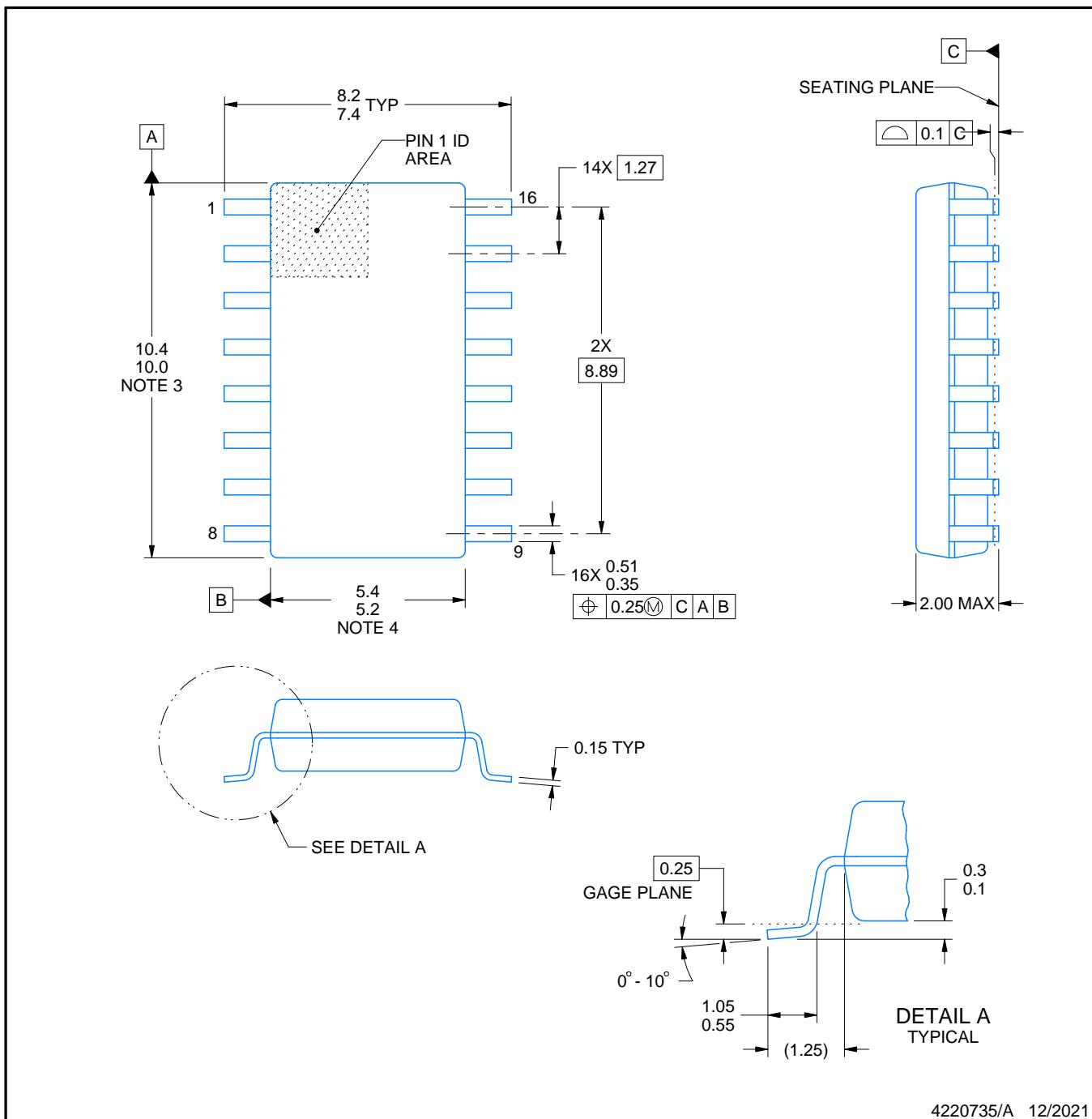
NS0016A



PACKAGE OUTLINE

SOP - 2.00 mm max height

SOP



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NOTES:

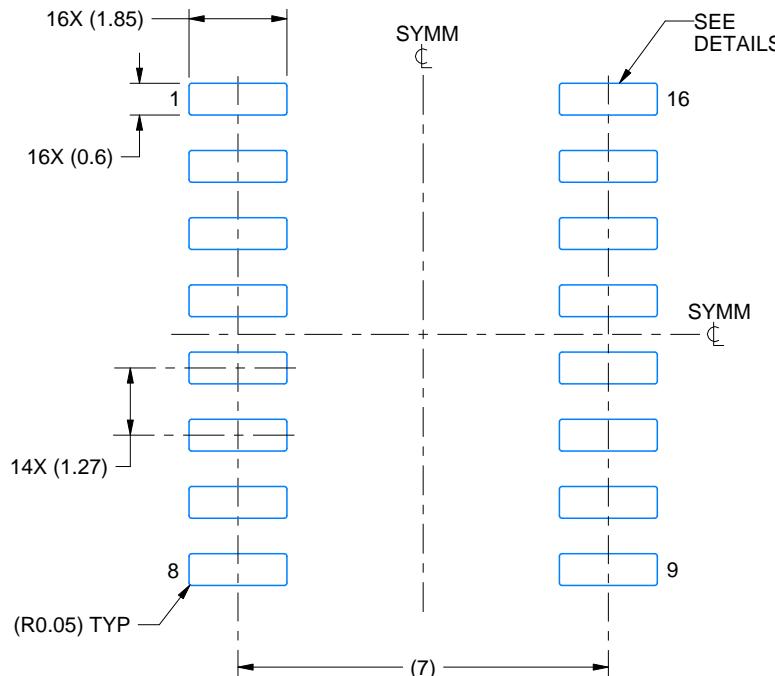
- All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.
- This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.

EXAMPLE BOARD LAYOUT

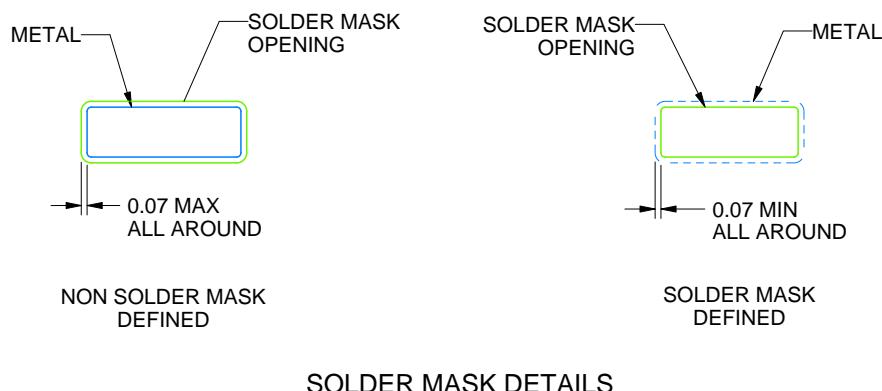
NS0016A

SOP - 2.00 mm max height

SOP



LAND PATTERN EXAMPLE
SCALE:7X



4220735/A 12/2021

NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

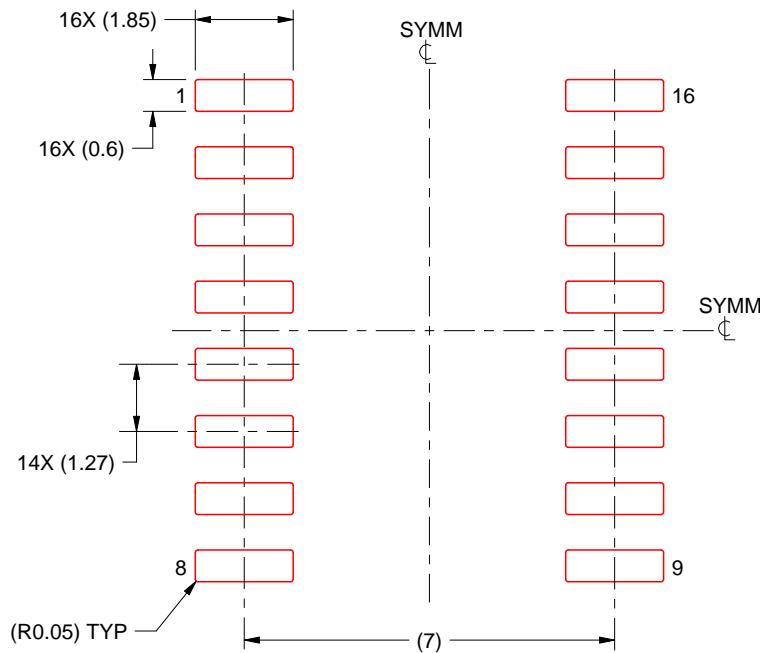
6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

NS0016A

SOP - 2.00 mm max height

SOP



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:7X

4220735/A 12/2021

NOTES: (continued)

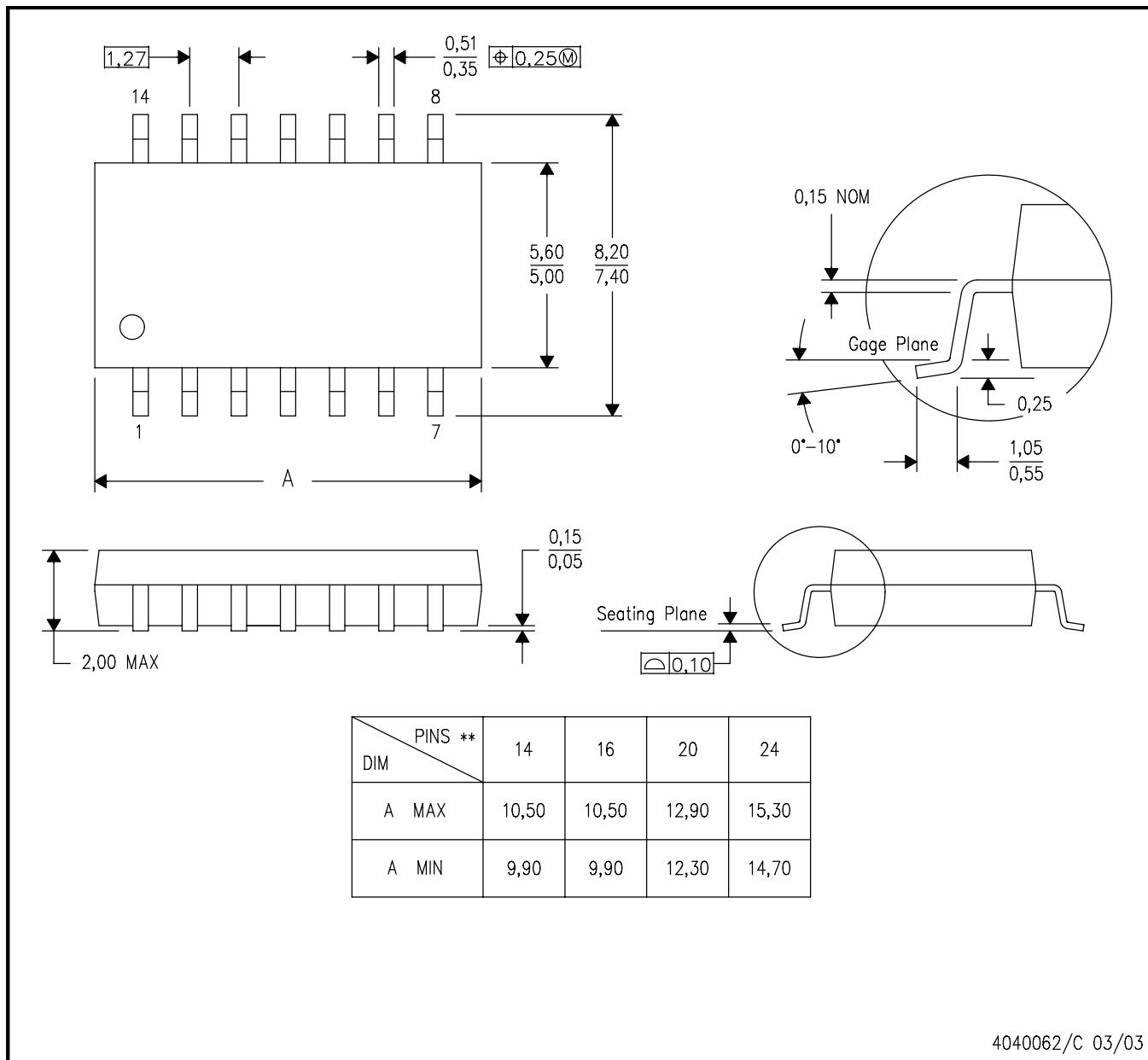
7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

MECHANICAL DATA

NS (R-PDSO-G)**

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES: A. All linear dimensions are in millimeters.
 B. This drawing is subject to change without notice.
 C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

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